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ON Semiconductor®

FDS9958-F085

Dual P-Channel PowerTrench[®] MOSFET -60V, -2.9A, $105m\Omega$

Features

- Max $r_{DS(on)}$ =105m Ω at V_{GS} = -10V, I_D = -2.9A
- Max $r_{DS(on)}$ =135m Ω at V_{GS} = -4.5V, I_D = -2.5A
- Qualified to AEC Q101
- RoHS Compliant



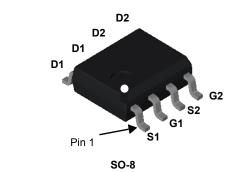
General Description

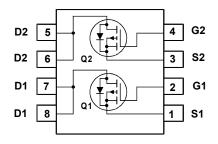
These P-channel logic level specified MOSFETs are produced using ON Semiconductor's advanced PowerTrench[®] process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices are well suited for portable electronics applications: load switching and power management, battery charging and protection circuits.

Applications

- Load Switch
- Power Management





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DS}	Drain to Source Voltage	-60	V	
V _{GS}	Gate to Source Voltage		±20	V
ID	Drain Current -Continuous	(Note 1a)	-2.9	^
	-Pulsed		-12	Α
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	54	mJ
P _D	Power Dissipation for Dual Operation		2	
	Power Dissipation	(Note 1a)	1.6	W
	Power Dissipation	(Note 1b)	0.9	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	40	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	78	C/vv

Package Marking and Ordering Information

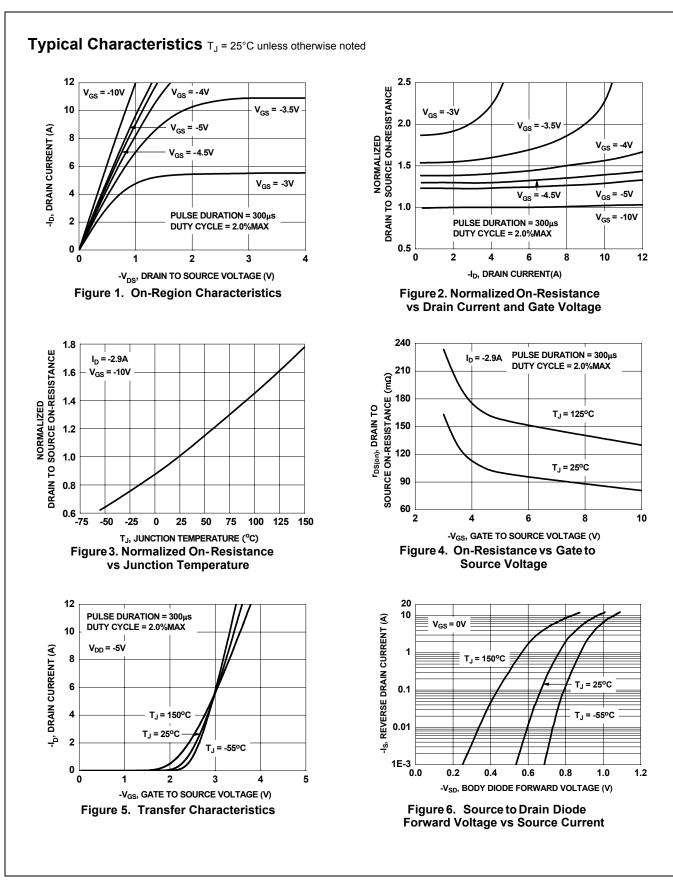
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS9958	FDS9958-F085	SO-8	330mm	12mm	2500units

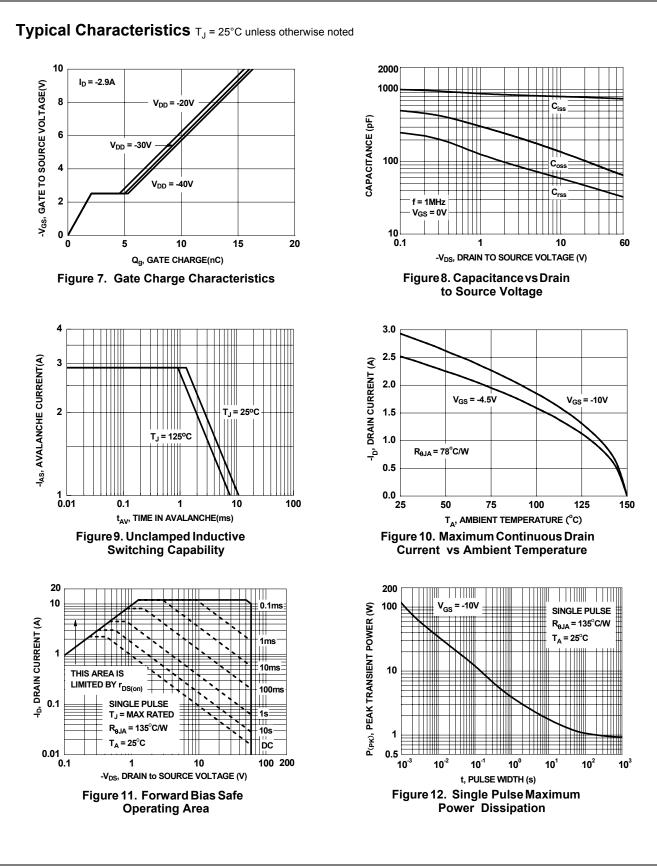
Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current	$I_D = -250\mu A$, $V_{GS} = 0V$ $I_D = -250\mu A$, referenced to 25°C	-60			
Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current	$I_D = -250 \mu A$, referenced to $25^{\circ}C$	-60			
Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current	$I_D = -250 \mu A$, referenced to $25^{\circ}C$				V
-	$\lambda = 40 \lambda$		-52		mV/°C
	V _{DS} = -48V, V _{GS} = 0V T _J = 125°C			-1 -100	μA
Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
octoristics				•	
		1.0	1.6	2.0	V
-	$v_{GS} = v_{DS}, \ I_D = -250 \mu A$	-1.0	-1.0	-3.0	v
Temperature Coefficient	I_D = -250µA, referenced to 25°C		4		mV/°C
Static Drain to Source On Resistance	V_{GS} = -10V, I_{D} = -2.9A		82	105	
			103	135	mΩ
	V_{GS} = -10V, I_D = -2.9A, T_J = 125°C		131	190	
Forward Transconductance	$V_{DD} = -5V, I_D = -2.9A$		7.7		S
Characteristics					
			765	1020	pF
	V _{DS} = -30V, V _{GS} = 0V,				pF
	f = 1MHz				pF
					р.
			-	10	1
	V _{DD} = -30V. I _D = -2.9A.		-		ns
	$-V_{GS} = -10V, R_{GEN} = 6\Omega$		-	-	ns
				-	ns
	$\lambda = 0 \lambda = 10 \lambda$		-		ns
-	$V_{GS} = 0V to -10V$ $V_{DD} = -30V,$			-	nC nC
-	$V_{GS} = 0.010 - 4.50$ $I_D = -2.9A$		-	12	nC
Gate to Drain "Miller" Charge			2		nC
			3		lic
-					
urce Diode Characteristics					
-	V _{GS} = 0V, I _S = -1.3A (Note 2)		-0.8	-1.2	V
urce Diode Characteristics	$V_{GS} = 0V, I_S = -1.3A$ (Note 2) $I_F = -2.9A, di/dt = 100A/\mu s$		-0.8 26	-1.2 42	V ns
	Static Drain to Source On Resistance	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$, $I_D = -250\mu A$ Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu A$, referenced to $25^{\circ}C$ $I_D = -250\mu A$, referenced to $25^{\circ}C$ $V_{GS} = -10V$, $I_D = -2.9A$ Static Drain to Source On Resistance $V_{GS} = -10V$, $I_D = -2.9A$ $V_{GS} = -10V$, $I_D = -2.9A$, $T_J = 125^{\circ}C$ Forward Transconductance $V_{DD} = -5V$, $I_D = -2.9A$ CharacteristicsInput Capacitance $V_{DS} = -30V$, $V_{GS} = 0V$, f = 1MHzReverse Transfer Capacitance $V_{DS} = -30V$, $V_{GS} = 0V$, f = 1MHzfurn-On Delay Time $V_{DD} = -30V$, $I_D = -2.9A$, $V_{GS} = -10V$, $R_{GEN} = 6\Omega$ Turn-Off Delay Time $V_{GS} = 0V$ to $-10V$ $V_{GS} = 0V to -4.5VTotal Gate ChargeV_{GS} = 0V to -4.5VI_D = -2.9A$	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$, $I_D = -250\mu A$ -1.0Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250\mu A$, referenced to $25^{\circ}C$ -1.0Static Drain to Source On Resistance $V_{GS} = -10V$, $I_D = -2.9A$ $V_{GS} = -4.5V$, $I_D = -2.9A$ Static Drain to Source On Resistance $V_{GS} = -10V$, $I_D = -2.9A$, $T_J = 125^{\circ}C$ Forward Transconductance $V_{DD} = -5V$, $I_D = -2.9A$, $T_J = 125^{\circ}C$ CharacteristicsInput Capacitance Output Capacitance $V_{DS} = -30V$, $V_{GS} = 0V$, f = 1MHzReverse Transfer Capacitance $V_{DD} = -30V$, $V_{GS} = 0V$, f = 1MHzfurn-On Delay Time Fall Time $V_{DD} = -30V$, $I_D = -2.9A$, $V_{GS} = -10V$, $R_{GEN} = 6\Omega$ Total Gate Charge $V_{GS} = 0V$ to $-10V$ $V_{GS} = 0V$ to $-10V$ $V_{DD} = -30V$, $I_D = -2.9A$	$\begin{array}{ c c c c } \hline Gate to Source Threshold Voltage & V_{GS} = V_{DS}, \ I_D = -250 \mu A & -1.0 & -1.6 \\ \hline Gate to Source Threshold Voltage Temperature Coefficient & I_D = -250 \mu A, referenced to 25°C & 4 \\ \hline I_D = -250 \mu A, referenced to 25°C & 4 \\ \hline V_{GS} = -10V, \ I_D = -2.9A & 82 \\ \hline V_{GS} = -4.5V, \ I_D = -2.9A & 103 \\ \hline V_{GS} = -10V, \ I_D = -2.9A, \ T_J = 125°C & 131 \\ \hline Forward Transconductance & V_{DD} = -5V, \ I_D = -2.9A & 7.7 \\ \hline Characteristics & \\ \hline Input Capacitance & V_{DS} = -30V, \ V_{GS} = 0V, \\ \hline Output Capacitance & f = 1MHz & 40 \\ \hline Other Capacitance & f = 1MHz & 40 \\ \hline Other Capacitance & V_{DD} = -30V, \ I_D = -2.9A, \\ \hline U_{DS} = -30V, \ I_D = -2.9A, \\ \hline V_{GS} = -10V, \ R_{GEN} = 6\Omega & 27 \\ \hline Fall Time & 6 \\ \hline Total Gate Charge & V_{GS} = 0V to -10V \\ \hline Total Gate Charge & V_{GS} = 0V to -4.5V \\ \hline I_D = -2.9A & 8 \\ \hline \end{array}$	$\begin{array}{ c c c c c c } \hline Gate to Source Threshold Voltage \\ \hline Gate to Source Threshold Voltage \\ \hline Temperature Coefficient } & I_D = -250 \mu A, referenced to 25°C \\ \hline & & I_D = -250 \mu A, referenced to 25°C \\ \hline & & & & & & & & & & & & & & & & & &$

2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

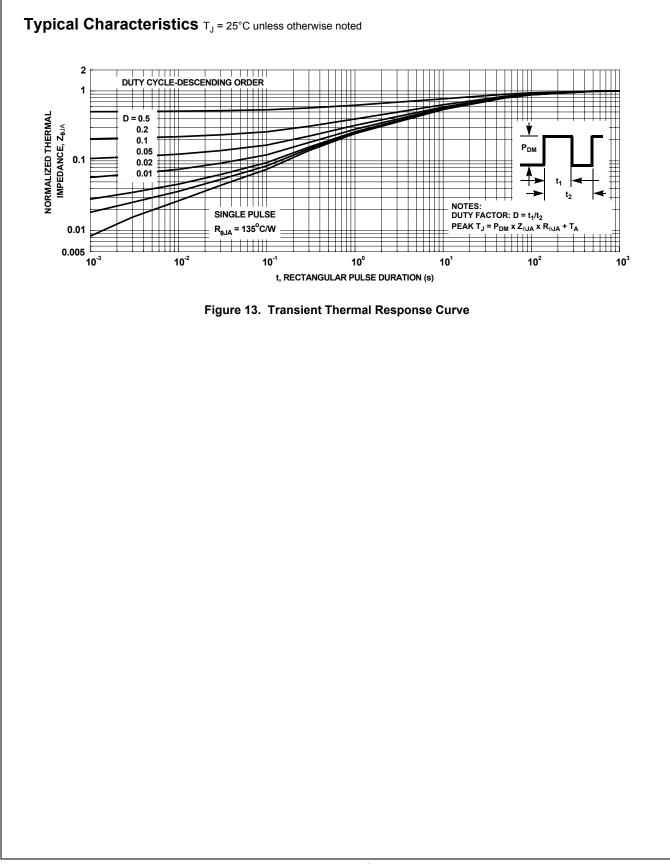
3. UIL condition: Starting T_J = 25°C, L = 3mH, I_{AS} = 6A, V_{DD} = 60V, V_{GS} = 10V.

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